

TC7SL00F, TC7SL00FU

2-INPUT NAND GATE

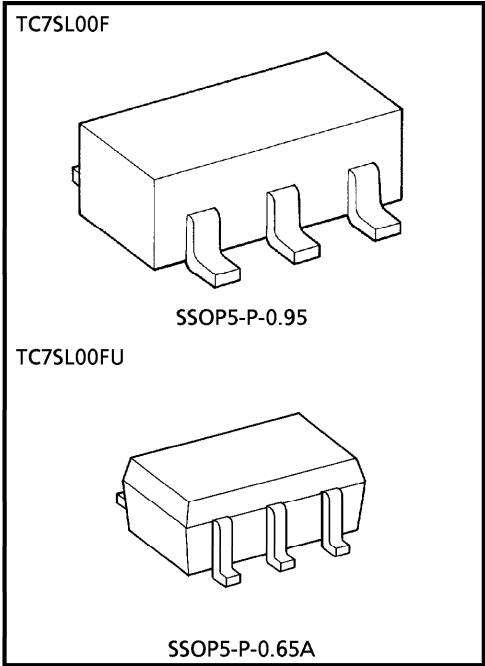
The TC7SL00 is a low voltage operative C<sup>2</sup>MOS 2-INPUT NAND GATE fabricated with silicon gate C<sup>2</sup>MOS technology.  
Operating voltage (V<sub>CC (opr)</sub>) is 1~3V equivalent to 1pc or 2pcs of dry cell battery and it achives low power dissipation.  
The internal circuit is composed of 3 stages including buffer output, which enables high noise immunity and stable output.  
All inputs are equipped with protection circuits against static discharge or transient excess voltage.

FEATURES

- High Speed ..... t<sub>pd</sub> = 10ns (Typ.)  
at V<sub>CC</sub> = 3V
- Low Power Dissipation ..... I<sub>CC</sub> = 1μA (Max.)  
at Ta = 25°C
- High Noise Immunity ..... V<sub>NIH</sub> = V<sub>NIL</sub>  
= 28% V<sub>CC</sub> (Min.)
- Symmetrical Output Impedance ..... |I<sub>OH</sub>| = I<sub>OL</sub> = 1mA
- Balanced Propagation Delay Time ... t<sub>pLH</sub> ≐ t<sub>pHL</sub>
- Low Voltage Operating ..... V<sub>CC (opr)</sub> = 1~3.6V

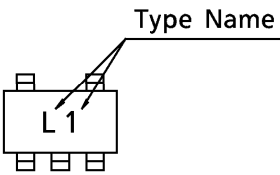
MAXIMUM RATINGS

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage Range	V <sub>CC</sub>	- 0.5~5	V
DC Input Voltage	V <sub>IN</sub>	- 0.5~V <sub>CC</sub> + 0.5	V
DC Output Voltage	V <sub>OUT</sub>	- 0.5~V <sub>CC</sub> + 0.5	V
Input Diode Current	I <sub>IK</sub>	± 20	mA
Output Diode Current	I <sub>OK</sub>	± 20	mA
DC Output Current	I <sub>OUT</sub>	± 12.5	mA
DC V <sub>CC</sub> / Ground Current	I <sub>CC</sub>	± 25	mA
Power Dissipation	P <sub>D</sub>	200	mW
Storage Temperature	T <sub>stg</sub>	- 65~150	°C
Lead Temperature (10s)	T <sub>L</sub>	260	°C

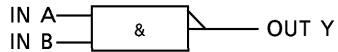


Weight SSOP5-P-0.95 : 0.016g (Typ.)  
SSOP5-P-0.65A : 0.006g (Typ.)

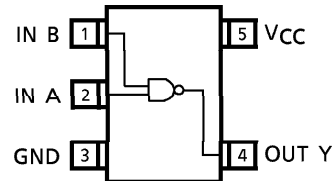
MARKING



## LOGIC DIAGRAM



## PIN CONNECTION (TOP VIEW)



## RECOMMENDED OPERATING CONDITIONS

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	$V_{CC}$	1~3.6	V
Input Voltage	$V_{IN}$	0~ $V_{CC}$	V
Output Voltage	$V_{OUT}$	0~ $V_{CC}$	V
Operating Temperature	$T_{opr}$	-40~85	°C
Input Rise and Fall Time	$t_r, t_f$	0~1000 ( $V_{CC} = 1.0V$ )	ns
		0~500 ( $V_{CC} = 1.5V$ )	
		0~400 ( $V_{CC} = 3.0V$ )	

## DC ELECTRICAL CHARACTERISTICS

CHARACTERISTIC	SYMBOL	TEST CIRCUIT	TEST CONDITION	$V_{CC}$	$T_a = 25^{\circ}C$			$T_a = -40 \sim 85^{\circ}C$		UNIT
					MIN.	TYP.	MAX.	MIN.	MAX.	
High-Level Input Voltage	$V_{IH}$	—	—	1.0 1.5 3.0	0.75 1.05 2.10	— — —	— — —	0.75 1.05 2.10	— — —	V
Low-Level Input Voltage	$V_{IL}$	—	—	1.0 1.5 3.0	— — —	— — —	0.25 0.45 0.90	— — —	0.25 0.45 0.90	V
High-Level Output Voltage	$V_{OH}$	—	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -20\mu A$	1.0 1.5 3.0	0.9 1.4 2.9	1.0 1.5 3.0	— — —	0.9 1.4 2.9	V
				$I_{OH} = -1mA$	1.5 3.0	1.07 2.61	1.23 2.68	— —	0.99 2.55	
				$I_{OH} = -2.6mA$	3.0	2.61	2.68	—	2.55	
Low-Level Output Voltage	$V_{OL}$	—	$V_{IN} = V_{IH}$	$I_{OL} = 20\mu A$	1.0 1.5 3.0	— — —	0.0 0.0 0.0	0.1 0.1 0.1	— — —	V
				$I_{OL} = 1mA$	1.5 3.0	— —	0.23 0.23	0.31 0.31	— —	
				$I_{OL} = 2.6mA$	3.0	—	0.23	0.31	—	
Input Leakage Current	$I_{IN}$	—	$V_{IN} = V_{CC}$ or GND	3.6	—	—	$\pm 0.1$	—	$\pm 1.0$	$\mu A$
Quiescent Supply Current	$I_{CC}$	—	$V_{IN} = V_{CC}$ or GND	3.6	—	—	1.0	—	10.0	

AC ELECTRICAL CHARACTERISTICS (C<sub>L</sub> = 15pF, Input t<sub>r</sub> = t<sub>f</sub> = 6ns, V<sub>CC</sub> = 3.3 ± 0.3V)

CHARACTERISTIC	SYMBOL	TEST CIRCUIT	TEST CONDITION	Ta = 25°C			UNIT
				MIN.	TYP.	MAX.	
Output Transition Time	t <sub>TLH</sub> t <sub>THL</sub>	—	—	—	5.0	9.0	ns
Propagation Delay Time	t <sub>PLH</sub> t <sub>PHL</sub>	—	—	—	7.5	13.0	ns

AC ELECTRICAL CHARACTERISTICS (C<sub>L</sub> = 25pF, Input t<sub>r</sub> = t<sub>f</sub> = 6ns)

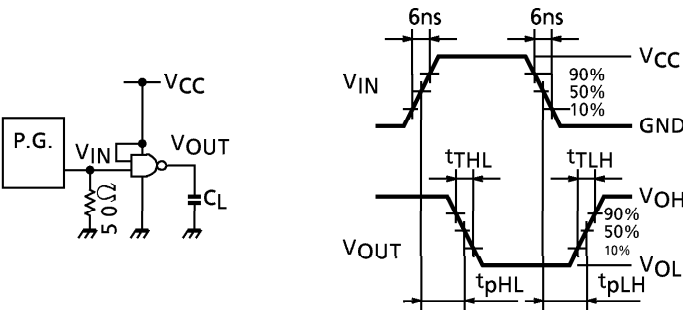
CHARACTERISTIC	SYMBOL	TEST CIRCUIT	TEST CONDITION	V <sub>CC</sub>	Ta = 25°C			Ta = -40~85°C		UNIT
					MIN.	TYP.	MAX.	MIN.	MAX.	
Output Transition Time	t <sub>TLH</sub> t <sub>THL</sub>	—	—	1.0	—	70	170	—	240	ns
				1.5	—	25	45	—	55	
				3.0	—	10	15	—	20	
Propagation Delay Time	t <sub>PLH</sub> t <sub>PHL</sub>	—	—	1.0	—	70	170	—	210	ns
				1.5	—	25	45	—	55	
				3.0	—	10	15	—	20	
Input Capacitance	C <sub>IN</sub>	—	—	—	—	5	10	—	10	pF
Power Dissipation Capacitance	C <sub>PD</sub>	—	Note (1)	—	—	10	—	—	—	

Note (1) : C<sub>PD</sub> defined as the value of internal equivalent capacitance of IC which is calculated from the operating current consumption without load (refer to Test Circuit).

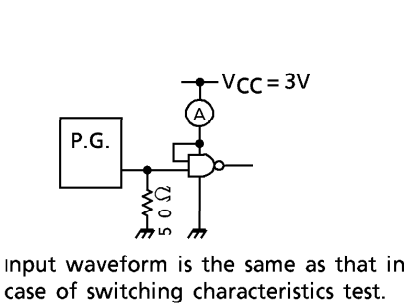
Average operating current can be obtained by the equation as follows.

$$I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

SWITCHING CHARACTERISTICS TEST CIRCUIT

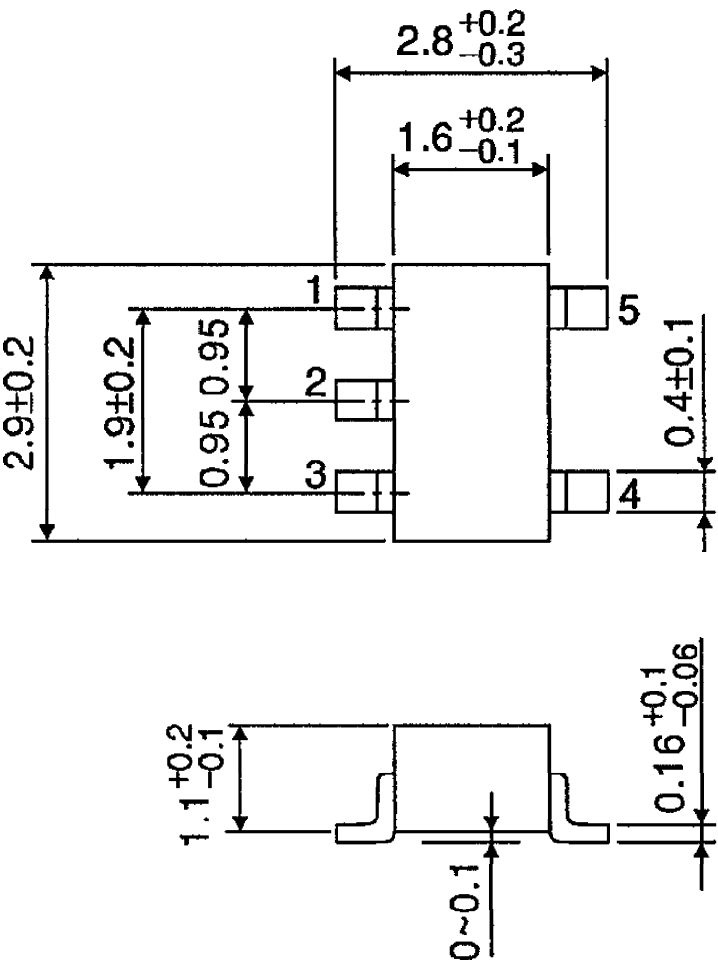


I<sub>CC (opr)</sub> TEST CIRCUIT



PACKAGE DIMENSIONS  
SSOP5-P-0.95

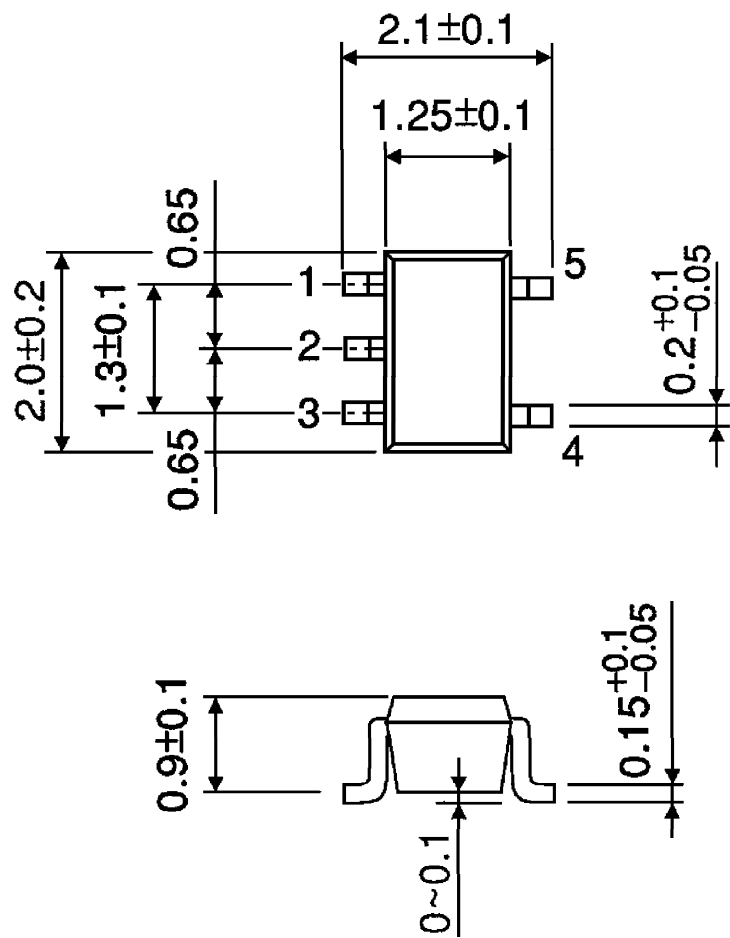
Unit : mm



Weight : 0.016g (Typ.)

PACKAGE DIMENSIONS  
SSOP5-P-0.65A

Unit : mm



Weight : 0.006g (Typ.)

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000707EBA

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